

**Search Notes**

Application/Control No.

10/526,105

Examiner

Benny Lee

Applicant(s)/Patent under  
Reexamination

SAITOH, ATSUSHI

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
333	26,248	10/6/2006	BTL
Rsch	above	3/7/2007	BTL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
333	26,248	3/9/2007	BTL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR